

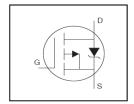
### **AUTOMOTIVE GRADE**

AUIRF4905

HEXFET® Power MOSFET

### **Features**

- Advanced Planar Technology
- Low On-Resistance
- Dynamic dV/dT Rating
- 175°C Operating Temperature
- Fast Switching
- · Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Timax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*



V <sub>DSS</sub>	-55V
R <sub>DS(on)</sub> max.	0.02Ω
I <sub>D</sub>	-74A



G	D	S
Gate	Drain	Source

### Description

Specifically designed for Automotive applications, this cellular design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.

Base next number	Dookogo Typo	Standard Pack Form Quantity		Ordereble Bort Number
Base part number	Package Type			Orderable Part Number
AUIRF4905	TO-220	Tube	50	AUIRF4905

### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	-74	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	-52	Α
I <sub>DM</sub>	Pulsed Drain Current ①	-260	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	200	W
	Linear Derating Factor	1.3	W/°C
V <sub>GS</sub> Gate-to-Source Voltage		± 20	V
E <sub>AS</sub> Single Pulse Avalanche Energy (Thermally Limited) ②		930	mJ
I <sub>AR</sub> Avalanche Current ①		-38	А
E <sub>AR</sub>	Repetitive Avalanche Energy ①	20	mJ
dv/dt Peak Diode Recovery dv/dt®		-5.0	V/ns
T <sub>J</sub>	Operating Junction and	-55 to + 175	
$T_{STG}$	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case ⑦		0.75	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient		62	

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1 2015-11-9

<sup>\*</sup>Qualification standards can be found at www.infineon.com



# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-55			V	$V_{GS} = 0V, I_{D} = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		-0.05		V/°C	Reference to 25°C, I <sub>D</sub> = -1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			0.02	Ω	$V_{GS} = -10V, I_{D} = -38A \oplus$
$V_{GS(th)}$	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
gfs	Forward Trans conductance	21			S	$V_{DS} = -25V, I_{D} = -38A$
	Drain-to-Source Leakage Current			-25	uА	$V_{DS} = -55V, V_{GS} = 0V$
IDSS	Drain-to-Source Leakage Current			-250	μΑ	$V_{DS} = -44V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			-100	n ^	V <sub>GS</sub> = -20V
	Gate-to-Source Reverse Leakage			100	nA	V <sub>GS</sub> = 20V

# Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

•	O , ,	•	,		
$Q_g$	Total Gate Charge	 	180		I <sub>D</sub> = -38A
$Q_{gs}$	Gate-to-Source Charge	 	32	nC	$V_{DS} = -44V$
$Q_{gd}$	Gate-to-Drain Charge	 	86		V <sub>GS</sub> = -10V,See Fig 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	 18			$V_{DD} = -28V$
t <sub>r</sub>	Rise Time	 99		no	$I_{D} = -38A$
$t_{d(off)}$	Turn-Off Delay Time	 61		ns	$R_G = 2.5\Omega$ ,
$t_f$	Fall Time	 96			R <sub>D</sub> = 0.72Ω, See Fig. 10 ④
$L_D$	Internal Drain Inductance	 4.5			Between lead, 6mm (0.25in.)
Ls	Internal Source Inductance	 7.5		1111	from package and center of die contacτ
$C_{iss}$	Input Capacitance	 3400			$V_{GS} = 0V$
Coss	Output Capacitance	 1400		pF	$V_{DS} = -25V$
C <sub>rss</sub>	Reverse Transfer Capacitance	 640		-	f = 1.0MHz, See Fig. 5

# Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)			-74		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①			-260		integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage			-1.6	V	$T_J = 25^{\circ}C, I_S = -38A, V_{GS} = 0V $ ④
t <sub>rr</sub>	Reverse Recovery Time		89	130	ns	$T_J = 25^{\circ}C$ , $I_F = -38A$
$Q_{rr}$	Reverse Recovery Charge		230	350	nC	di/dt = 100A/µs ④
t <sub>on</sub>	Forward Turn-On Time	Intrinsi	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )			

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig.11)
- © Starting  $T_J$  = 25°C, L = 1.3mH,  $R_G$  = 25 $\Omega$ ,  $I_{AS}$  = -38A. (See Figure 12) ③  $I_{SD} \le$  -38A,  $di/dt \le$  -270A/ $\mu$ s,  $V_{DD} \le V_{BR}$ )DSS,  $T_J \le$  175°C



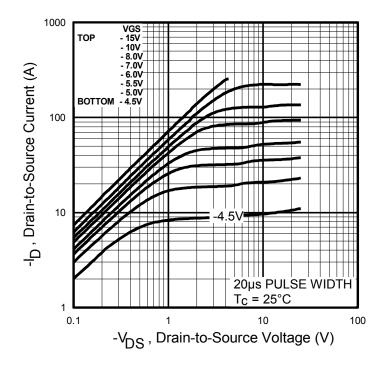


Fig. 1 Typical Output Characteristics

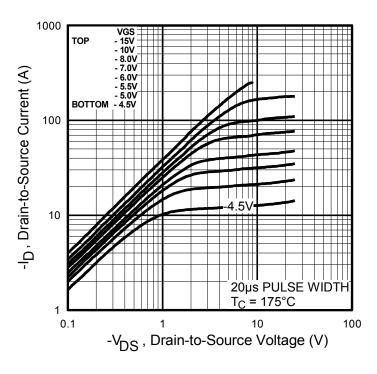


Fig. 2 Typical Output Characteristics

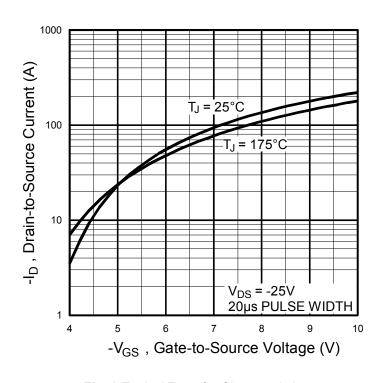
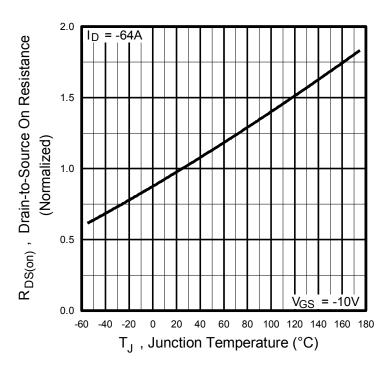


Fig. 3 Typical Transfer Characteristics



**Fig. 4** Normalized On-Resistance Vs. Temperature



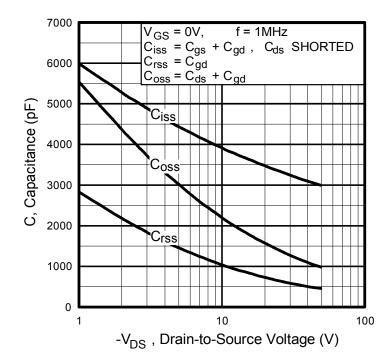


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

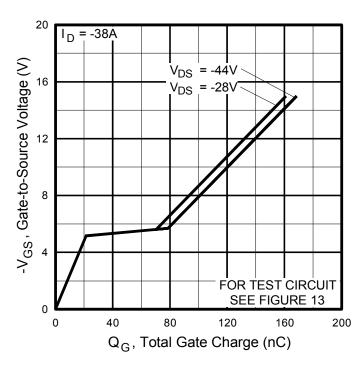
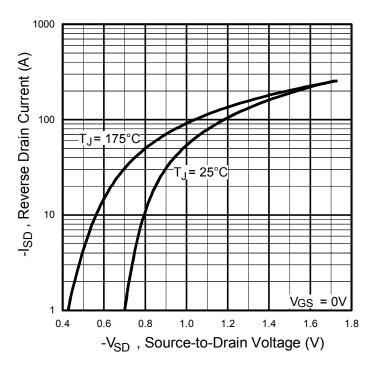


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



**Fig. 7** Typical Source-to-Drain Diode Forward Voltage

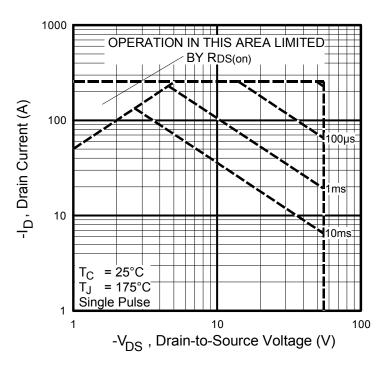


Fig 8. Maximum Safe Operating Area



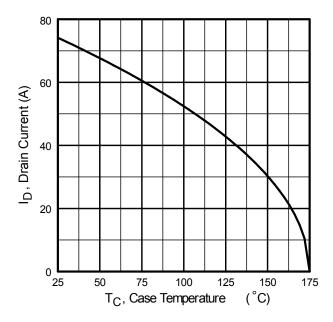


Fig 9. Maximum Drain Current vs.

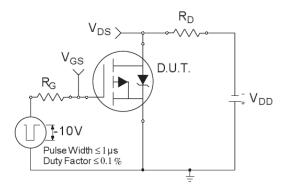


Fig 10a. Switching Time Test Circuit

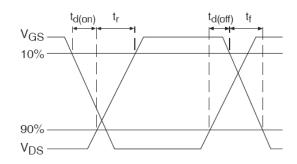


Fig 10b. Switching Time Waveforms

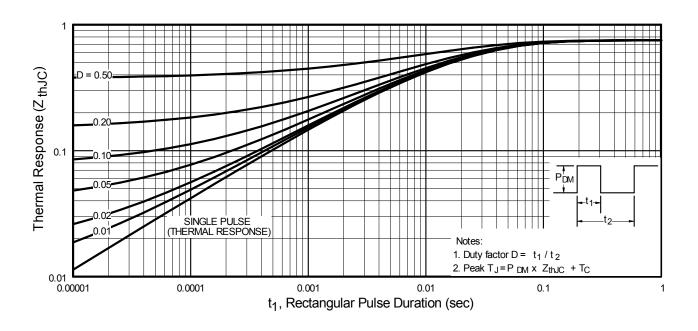


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



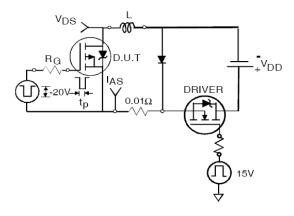
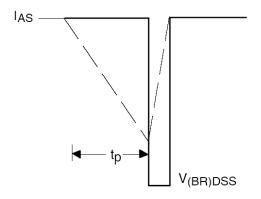
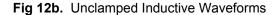


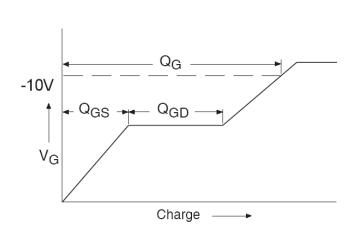
Fig 12a. Unclamped Inductive Test Circuit



2500  $I_D$ Single Pulse Avalanche Energy (mJ) TOP -16A -27A BOTTOM -38A 2000 1500 1000 500 E<sub>AS</sub> , 50 25 75 100 125 150 175 Starting T<sub>J</sub>, Junction Temperature (°C)

Fig 12c. Maximum Avalanche Energy vs. Drain Current





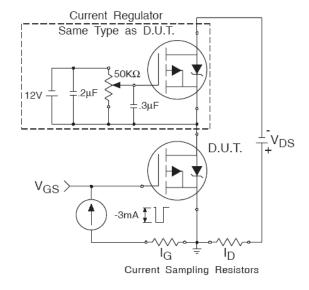
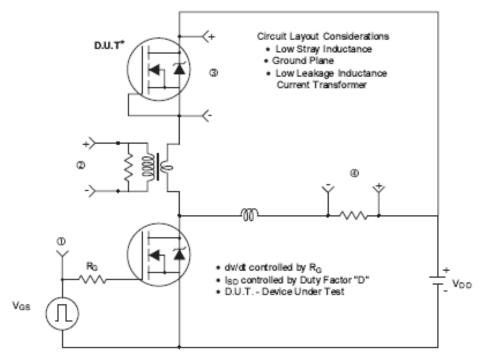


Fig 13a. Gate Charge Waveform

Fig 13b. Gate Charge Test Circuit





\* Reverse Polarity of D.U.T for P-Channel

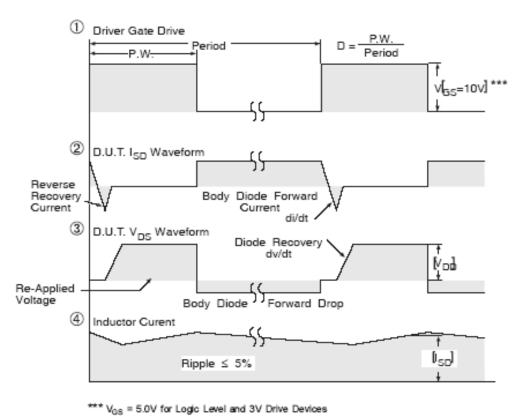
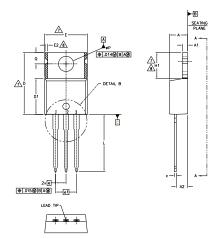
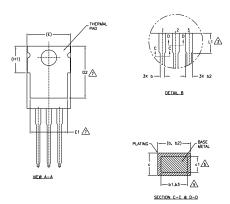


Fig 14. Peak Diode Recovery dv/dt Test Circuit for P-Channel HEXFET® Power MOSFETs



## TO-220AB Package Outline (Dimensions are shown in millimeters (inches))





### NOTES:

- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.

- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].

  LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.

  DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH
  SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
  - DIMENSION b1, b3 & c1 APPLY TO BASE METAL ONLY.
- CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.
- OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

SYMBOL	MILLIM	ETERS	INC	HES	
	MIN.	MAX.	MIN.	MAX.	NOTES
Α	3.56	4.83	.140	.190	
A1	1,14	1.40	.045	.055	
A2	2.03	2.92	.080	.115	
b	0.38	1.01	.015	.040	
ь1	0.38	0.97	.015	.038	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
С	0.36	0.61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	11.68	12.88	.460	.507	7
E	9.65	10.67	.380	.420	4,7
E1	6.86	8.89	.270	.350	7
E2	-	0.76	_	.030	8
е	2.54	BSC	.100		
e1	5.08	BSC	.200	BSC	
H1	5.84	6.86	.230	.270	7,8
L	12.70	14.73	.500	.580	
L1	3.56	4.06	.140	.160	3
øΡ	3.54	4.08	.139	.161	
Q	2.54	3.42	.100	.135	

### LEAD ASSIGNMENTS

### HEXFET

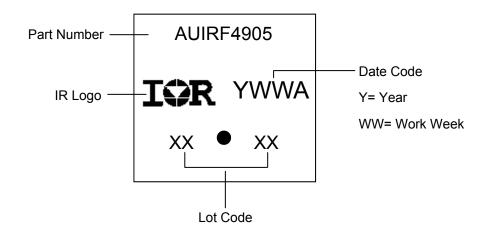
1.- GATE 2.- DRAIN 3.- SOURCE

IGBTs, CoPACK 1.- GATE 2.- COLLECTOR 3.- EMITTER

DIODES

1.- ANODE 2.- CATHODE 3.- ANODE

## **TO-220 Part Marking Information**



Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>



### Qualification Information

		Automotive (per AEC-Q101)				
Qualificat	tion Level	Comments: This part number(s) passed Automotive qualification. Infined Industrial and Consumer qualification level is granted by extension of the hig Automotive level.				
Moisture	Sensitivity Level	3L-TO-220 N/A				
	Machine Model	Class M4 (+/- 425V) <sup>†</sup>				
	Wacrime Woder	AEC-Q101-002				
ECD	Human Dady Madal	Class H2 (+/- 4000V) <sup>†</sup>				
ESD	Human Body Model	AEC-Q101-001				
Charged Device Model		Class C5 (+/- 1125V) <sup>†</sup>				
		AEC-Q101-005				
RoHS Co	mpliant	Yes				

<sup>†</sup> Highest passing voltage.

### **Revision History**

Date	Comments			
09/20/2017	Updated datasheet with corporate template			
09/20/2017	<ul> <li>Corrected typo error on package outline and part marking on page 8.</li> </ul>			

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